

IMPORTANT NOTICE

USAGE OF THE DAE4 SN: 874

The DAE unit is a delicate, high precision instrument and requires careful treatment by the user. There are no serviceable parts inside the DAE. Special attention must be given to the following points:

Battery Exchange: The battery cover of the DAE4 unit is closed using a screw, over tightening the screw may cause the threads inside the DAE to wear out.

Shipping of the DAE: Before shipping the DAE to SPEAG for calibration, remove the batteries and pack the DAE in an antistatic bag. This antistatic bag shall then be packed into a larger box or container which protects the DAE from impacts during transportation. The package shall be marked to indicate that a fragile instrument is inside.

E-Stop Failures: Touch detection may be malfunctioning due to broken magnets in the E-stop. Rough handling of the E-stop may lead to damage of these magnets. Touch and collision errors are often caused by dust and dirt accumulated in the E-stop. To prevent E-stop failure, the customer shall always mount the probe to the DAE carefully and keep the DAE unit in a non-dusty environment if not used for measurements.

Repair: Minor repairs are performed at no extra cost during the calibration. However, SPEAG reserves the right to charge for any repair especially if rough unprofessional handling caused the defect.

DASY Configuration Files: Since the exact values of the DAE input resistances, as measured during the calibration procedure of a DAE unit, are not used by the DASY software, a nominal value of 200 MOhm is given in the corresponding configuration file.

Important Note:

Warranty and calibration is void if the DAE unit is disassembled partly or fully by the Customer.

Important Note:

Never attempt to grease or oil the E-stop assembly. Cleaning and readjusting of the E-stop assembly is allowed by certified SPEAG personnel only and is part of the calibration procedure.

Important Note:

To prevent damage of the DAE probe connector pins, use great care when installing the probe to the DAE. Carefully connect the probe with the connector notch oriented in the mating position. Avoid any rotational movement of the probe body versus the DAE while turning the locking nut of the connector. The same care shall be used when disconnecting the probe from the DAE.



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Multilateral Agreement for the recognition of calibration certificates

Accreditation No.: **SCS 0108**

Client **Ultratech Labs**
Oakville - Canada

Certificate No: **DAE4-874_Jul25**

CALIBRATION CERTIFICATE

Object **DAE4 - SD 000 D04 BO - SN: 874**

Calibration procedure(s) **QA CAL-06.v30**
Calibration procedure for the data acquisition electronics (DAE)

Calibration date: **July 29, 2025**

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature (22 ± 3)°C and humidity < 70%.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID #	Cal Date (Certificate No.)	Scheduled Calibration
Keithley Multimeter Type 2001	SN: 0810278	27-Aug-24 (No:40547)	Aug-25
Secondary Standards	ID #	Check Date (in house)	Scheduled Check
Auto DAE Calibration Unit	SE UWS 053 AA 1001	23-Jan-25 (in house check)	In house check: Jan-26
Calibrator Box V2.1	SE UMS 006 AA 1002	23-Jan-25 (in house check)	In house check: Jan-26

Calibrated by:	Name Timo Rott	Function Laboratory Technician	Signature 
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Approved by:	Sven Kühn	Technical Manager
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Issued: July 29, 2025

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Glossary

DAE data acquisition electronics
Connector angle information used in DASY system to align probe sensor X to the robot coordinate system.

Methods Applied and Interpretation of Parameters

- *DC Voltage Measurement:* Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- *Connector angle:* The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters as documented in the Appendix contain technical information as a result from the performance test and require no uncertainty.
 - *DC Voltage Measurement Linearity:* Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
 - *Common mode sensitivity:* Influence of a positive or negative common mode voltage on the differential measurement.
 - *Channel separation:* Influence of a voltage on the neighbor channels not subject to an input voltage.
 - *AD Converter Values with inputs shorted:* Values on the internal AD converter corresponding to zero input voltage
 - *Input Offset Measurement:* Output voltage and statistical results over a large number of zero voltage measurements.
 - *Input Offset Current:* Typical value for information; Maximum channel input offset current, not considering the input resistance.
 - *Input resistance:* Typical value for information: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
 - *Low Battery Alarm Voltage:* Typical value for information. Below this voltage, a battery alarm signal is generated.
 - *Power consumption:* Typical value for information. Supply currents in various operating modes.

DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: 1LSB = 6.1 μ V, full range = -100...+300 mV

Low Range: 1LSB = 61 nV, full range = -1.....+3mV

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	X	Y	Z
High Range	404.322 $\pm$ 0.02% (k=2)	404.807 $\pm$ 0.02% (k=2)	404.381 $\pm$ 0.02% (k=2)
Low Range	3.99922 $\pm$ 1.50% (k=2)	4.01696 $\pm$ 1.50% (k=2)	4.01364 $\pm$ 1.50% (k=2)

Connector Angle

Connector Angle to be used in DASY system	125.0 ° $\pm$ 1 °
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Appendix (Additional assessments outside the scope of SCS0108)

1. DC Voltage Linearity

High Range		Reading (μV)	Difference (μV)	Error (%)
Channel X	+ Input	199995.53	-0.26	-0.00
Channel X	+ Input	20003.71	2.42	0.01
Channel X	- Input	-20001.07	2.72	-0.01
Channel Y	+ Input	199994.68	-1.10	-0.00
Channel Y	+ Input	20000.17	-1.20	-0.01
Channel Y	- Input	-20005.19	-1.56	0.01
Channel Z	+ Input	199995.25	-0.36	-0.00
Channel Z	+ Input	20000.63	-0.76	-0.00
Channel Z	- Input	-20005.75	-1.89	0.01

Low Range		Reading (μV)	Difference (μV)	Error (%)
Channel X	+ Input	1999.57	-0.03	-0.00
Channel X	+ Input	199.98	0.26	0.13
Channel X	- Input	-199.51	0.54	-0.27
Channel Y	+ Input	1999.63	0.04	0.00
Channel Y	+ Input	199.21	-0.51	-0.26
Channel Y	- Input	-200.99	-1.09	0.54
Channel Z	+ Input	1999.56	-0.01	-0.00
Channel Z	+ Input	199.45	-0.21	-0.10
Channel Z	- Input	-200.75	-0.82	0.41

2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	-8.77	-10.52
	- 200	11.79	10.30
Channel Y	200	2.85	2.62
	- 200	-5.03	-5.22
Channel Z	200	5.73	5.54
	- 200	-7.18	-7.19

3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (μV)	Channel Z (μV)
Channel X	200	-	-1.65	-2.91
Channel Y	200	5.55	-	-0.31
Channel Z	200	9.41	3.06	-

4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15815	14993
Channel Y	15909	15045
Channel Z	16119	15195

5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Input 10M Ω

	Average (μ V)	min. Offset (μ V)	max. Offset (μ V)	Std. Deviation (μ V)
Channel X	1.27	0.56	2.21	0.35
Channel Y	-0.86	-1.66	0.95	0.40
Channel Z	0.09	-0.58	0.85	0.29

6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance (Typical values for information)

	Zeroing (kOhm)	Measuring (MOhm)
Channel X	200	200
Channel Y	200	200
Channel Z	200	200

8. Low Battery Alarm Voltage (Typical values for information)

Typical values	Alarm Level (VDC)
Supply (+ Vcc)	+7.9
Supply (- Vcc)	-7.6

9. Power Consumption (Typical values for information)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.01	+6	+14
Supply (- Vcc)	-0.01	-8	-9



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Accreditation No.: SCS 0108

Client

Ultratech Labs
Oakville, Canada

Certificate No.

ES-3250_Mar25

CALIBRATION CERTIFICATE

Object

ES3DV3 - SN:3250

Calibration procedure(s)

QA CAL-01.v10, QA CAL-12.v10, QA CAL-23.v6, QA CAL-25.v8
Calibration procedure for dosimetric E-field probes

Calibration date

March 10, 2025

This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature $(22 \pm 3)^\circ\text{C}$ and humidity $< 70\%$.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID	Calibration Date (Certificate No.)	Sched. Cal.
Power Sensor R&S NRP-33T	SN: 100967	28-Mar-24 (No. 217-04038)	Mar-25
Short [S6019i] + Attenuator [S6020i]	SN: L1119	26-Mar-24 (No. 217-04048)	Mar-25
OCP DAK-12	SN: 1016	24-Sep-24 (No. OCP-DAK12-1016_Sep24)	Sep-25
OCP DAK-3.5	SN: 1249	23-Sep-24 (No. OCP-DAK3.5-1249_Sep24)	Sep-25
Reference Probe EX3DV4	SN: 7349	10-Jan-25 (No. EX3-7349_Jan25)	Jan-26
DAE4	SN: 1301	07-Nov-24 (No. DAE4-1301_Nov24)	Nov-25

Secondary Standards	ID	Check Date (in house)	Sched. Check
ACAP 2020 Calibration Box	SN: L1404	30-Sep-24 (No. Report_ACAP2020E-Cave_20240930s)	Sep-25

	Name	Function	Signature
Calibrated by	Krešimir Franjić	Laboratory Technician	
Approved by	Sven Kühn	Technical Manager	
Issued: March 11, 2025			
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Glossary

TSL	tissue simulating liquid
NORM _{x,y,z}	sensitivity in free space
ConvF	sensitivity in TSL / NORM _{x,y,z}
DCP	diode compression point
CF	crest factor (1/duty_cycle) of the RF signal
A, B, C, D	modulation dependent linearization parameters
Polarization φ	φ rotation around probe axis
Polarization ϑ	ϑ rotation around an axis that is in the plane normal to probe axis (at measurement center), i.e., $\vartheta = 0$ is normal to probe axis
Connector Angle	information used in DASY system to align probe sensor X to the robot coordinate system

Calibration is Performed According to the Following Standards:

- IEC/IEEE 62209-1528, "Measurement Procedure For The Assessment Of Specific Absorption Rate Of Human Exposure To Radio Frequency Fields From Hand-Held And Body-Worn Wireless Communication Devices – Part 1528: Human Models, Instrumentation And Procedures (Frequency Range of 4 MHz to 10 GHz)", October 2020.
- KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz"

Methods Applied and Interpretation of Parameters:

- NORM_{x,y,z}**: Assessed for E-field polarization $\vartheta = 0$ ($f \leq 900$ MHz in TEM-cell; $f > 1800$ MHz: R22 waveguide). NORM_{x,y,z} are only intermediate values, i.e., the uncertainties of NORM_{x,y,z} does not affect the E²-field uncertainty inside TSL (see below ConvF).
- NORM(f)_{x,y,z}** = NORM_{x,y,z} * frequency_response (see Frequency Response Chart). This linearization is implemented in DASY4 software versions later than 4.2. The uncertainty of the frequency response is included in the stated uncertainty of ConvF.
- DCP_{x,y,z}**: DCP are numerical linearization parameters assessed based on the data of power sweep with CW signal. DCP does not depend on frequency nor media.
- PAR**: PAR is the Peak to Average Ratio that is not calibrated but determined based on the signal characteristics
- A_{x,y,z}; B_{x,y,z}; C_{x,y,z}; D_{x,y,z}; VR_{x,y,z}**: A, B, C, D are numerical linearization parameters assessed based on the data of power sweep for specific modulation signal. The parameters do not depend on frequency nor media. VR is the maximum calibration range expressed in RMS voltage across the diode.
- ConvF and Boundary Effect Parameters**: Assessed in flat phantom using E-field (or Temperature Transfer Standard for $f \leq 800$ MHz) and inside waveguide using analytical field distributions based on power measurements for $f > 800$ MHz. The same setups are used for assessment of the parameters applied for boundary compensation (alpha, depth) of which typical uncertainty values are given. These parameters are used in DASY4 software to improve probe accuracy close to the boundary. The sensitivity in TSL corresponds to NORM_{x,y,z} * ConvF whereby the uncertainty corresponds to that given for ConvF. A frequency dependent ConvF is used in DASY version 4.4 and higher which allows extending the validity from ± 50 MHz to ± 100 MHz.
- Spherical isotropy (3D deviation from isotropy)**: in a field of low gradients realized using a flat phantom exposed by a patch antenna.
- Sensor Offset**: The sensor offset corresponds to the offset of virtual measurement center from the probe tip (on probe axis). No tolerance required.
- Connector Angle**: The angle is assessed using the information gained by determining the NORM_x (no uncertainty required).

Parameters of Probe: ES3DV3 - SN:3250

Basic Calibration Parameters

	Sensor X	Sensor Y	Sensor Z	Unc (k = 2)
Norm ($\mu\text{V}/(\text{V}/\text{m})^2$) ^A	0.86	0.81	0.97	±10.1%
DCP (mV) ^B	105.9	105.8	104.9	±4.7%

Calibration Results for Modulation Response

UID	Communication System Name		A dB	B dB $\sqrt{\mu\text{V}}$	C	D dB	VR mV	Max dev.	Max Unc ^E k = 2
0	CW	X	0.00	0.00	1.00	0.00	144.9	±0.7%	±4.7%
		Y	0.00	0.00	1.00		139.2		
		Z	0.00	0.00	1.00		120.2		

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor k=2, which for a normal distribution corresponds to a coverage probability of approximately 95%.

^A The uncertainties of Norm X,Y,Z do not affect the E²-field uncertainty inside TSL (see Pages 5 and 6).

^B Linearization parameter uncertainty for maximum specified field strength.

^E Uncertainty is determined using the max. deviation from linear response applying rectangular distribution and is expressed for the square of the field value.

Parameters of Probe: ES3DV3 - SN:3250**Other Probe Parameters**

Sensor Arrangement	Triangular
Connector Angle	16.0°
Mechanical Surface Detection Mode	enabled
Optical Surface Detection Mode	disabled
Probe Overall Length	337 mm
Probe Body Diameter	10 mm
Tip Length	10 mm
Tip Diameter	4 mm
Probe Tip to Sensor X Calibration Point	2 mm
Probe Tip to Sensor Y Calibration Point	2 mm
Probe Tip to Sensor Z Calibration Point	2 mm
Recommended Measurement Distance from Surface	3 mm

Parameters of Probe: ES3DV3 - SN:3250

Calibration Parameter Determined in HSL

f (MHz) ^C	Relative Permittivity ^F	Conductivity ^F (S/m)	ConvF X	ConvF Y	ConvF Z	Alpha ^G	Depth ^G (mm)	Unc ^H (k = 2)
150	52.3	0.76	7.79	7.49	7.31	0.00	2.00	±13.3%
450	43.5	0.87	7.06	7.06	7.06	0.20	1.30	±13.3%
600	42.7	0.88	6.72	6.72	6.72	0.14	1.82	±13.3%
835	41.5	0.90	6.13	5.94	5.84	0.33	2.18	±11.0%
900	41.5	0.97	6.11	5.92	5.81	0.34	2.18	±11.0%
1640	40.2	1.31	5.26	5.09	5.01	0.34	2.18	±11.0%
1810	40.0	1.40	5.31	5.14	5.06	0.35	1.82	±11.0%
2450	39.2	1.80	4.65	4.51	4.43	0.35	2.32	±11.0%

^C Frequency validity above 300 MHz of ±100 MHz only applies for DASY v4.4 and higher (see Page 2), else it is restricted to ±50 MHz. The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band. Frequency validity below 300 MHz is ±10, 25, 40, 50 and 70 MHz for ConvF assessments at 30, 64, 128, 150 and 220 MHz respectively. Validity of ConvF assessed at 6 MHz is 4–9 MHz, and ConvF assessed at 13 MHz is 9–19 MHz. Above 5 GHz frequency validity can be extended to ±110 MHz.

^F The probes are calibrated using tissue simulating liquids (TSL) that deviate for ϵ and σ by less than ±5% from the target values (typically better than ±3%) and are valid for TSL with deviations of up to ±10% if SAR correction is applied.

^G Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than ±1% for frequencies below 3 GHz and below ±2% for frequencies between 3–6 GHz at any distance larger than half the probe tip diameter from the boundary.

^H The stated uncertainty is the total calibration uncertainty (k = 2) of Norm-ConvF. This is equivalent to the uncertainty component with the symbol CF in Table 9 of IEC/IEEE 62209-1528:2020.

Parameters of Probe: ES3DV3 - SN:3250

Calibration Parameter Determined in MSL

f (MHz) ^C	Relative Permittivity ^F	Conductivity ^F (S/m)	ConvF X	ConvF Y	ConvF Z	Alpha ^G	Depth ^G (mm)	Unc ^H (k = 2)
150	61.9	0.80	7.62	7.33	7.19	0.00	2.00	±13.3%
450	56.7	0.94	7.12	7.12	7.12	0.16	1.20	±13.3%
600	56.1	0.95	6.79	6.79	6.79	0.14	1.98	±13.3%
835	55.2	0.97	6.48	6.15	6.03	0.34	2.18	±11.0%
900	55.0	1.05	6.28	5.97	5.85	0.33	2.18	±11.0%
1640	53.7	1.42	5.22	4.96	4.86	0.33	2.18	±11.0%
1810	53.3	1.52	5.30	5.03	4.93	0.32	2.18	±11.0%
2450	52.7	1.95	4.65	4.41	4.33	0.31	1.84	±11.0%

^C Frequency validity above 300 MHz of ±100 MHz only applies for DASY v4.4 and higher (see Page 2), else it is restricted to ±50 MHz. The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band. Frequency validity below 300 MHz is ±10, 25, 40, 50 and 70 MHz for ConvF assessments at 30, 64, 128, 150 and 220 MHz respectively. Validity of ConvF assessed at 6 MHz is 4–9 MHz, and ConvF assessed at 13 MHz is 9–19 MHz. Above 5 GHz frequency validity can be extended to ±110 MHz.

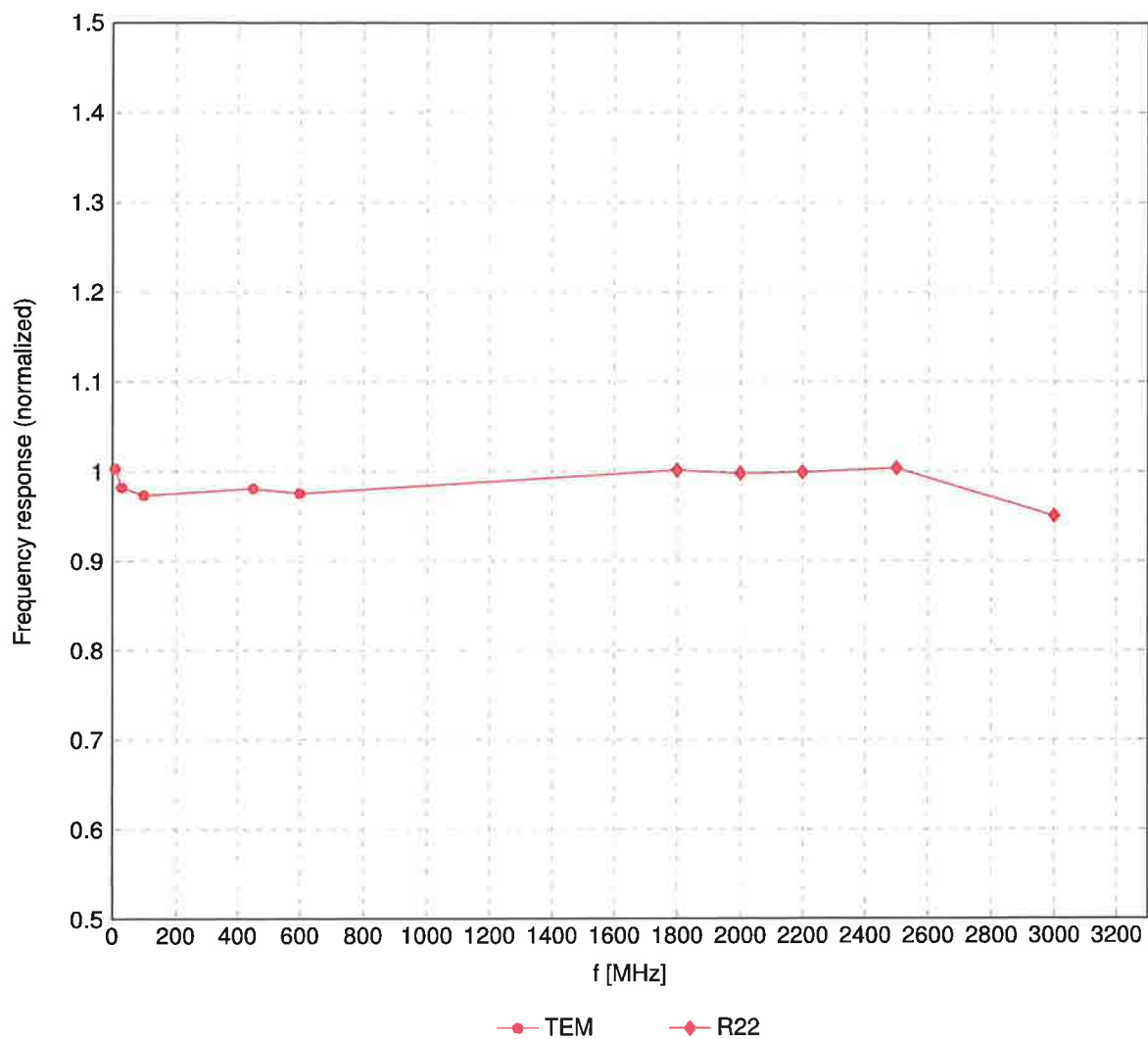
^F The probes are calibrated using tissue simulating liquids (TSL) that deviate for ϵ and σ by less than ±5% from the target values (typically better than ±3%) and are valid for TSL with deviations of up to ±10% if SAR correction is applied.

^G Alpha/Depth are determined during calibration. SPEAG warrants that the remaining deviation due to the boundary effect after compensation is always less than ±1% for frequencies below 3 GHz and below ±2% for frequencies between 3–6 GHz at any distance larger than half the probe tip diameter from the boundary.

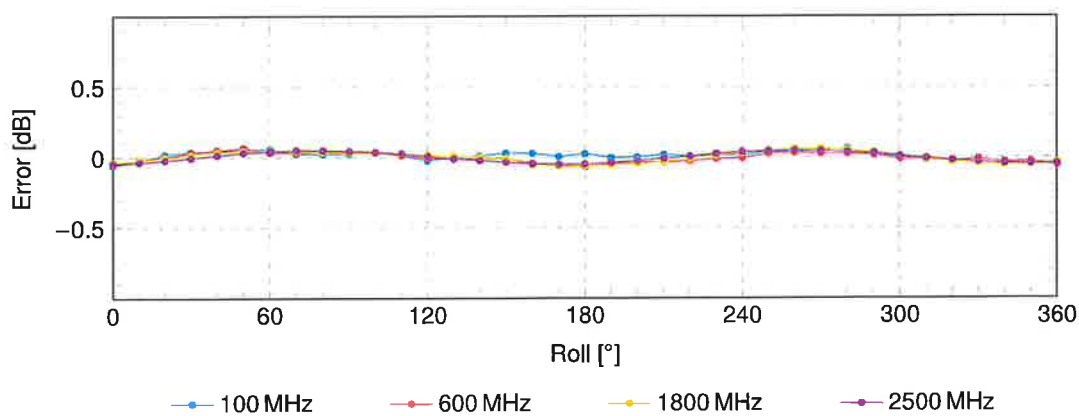
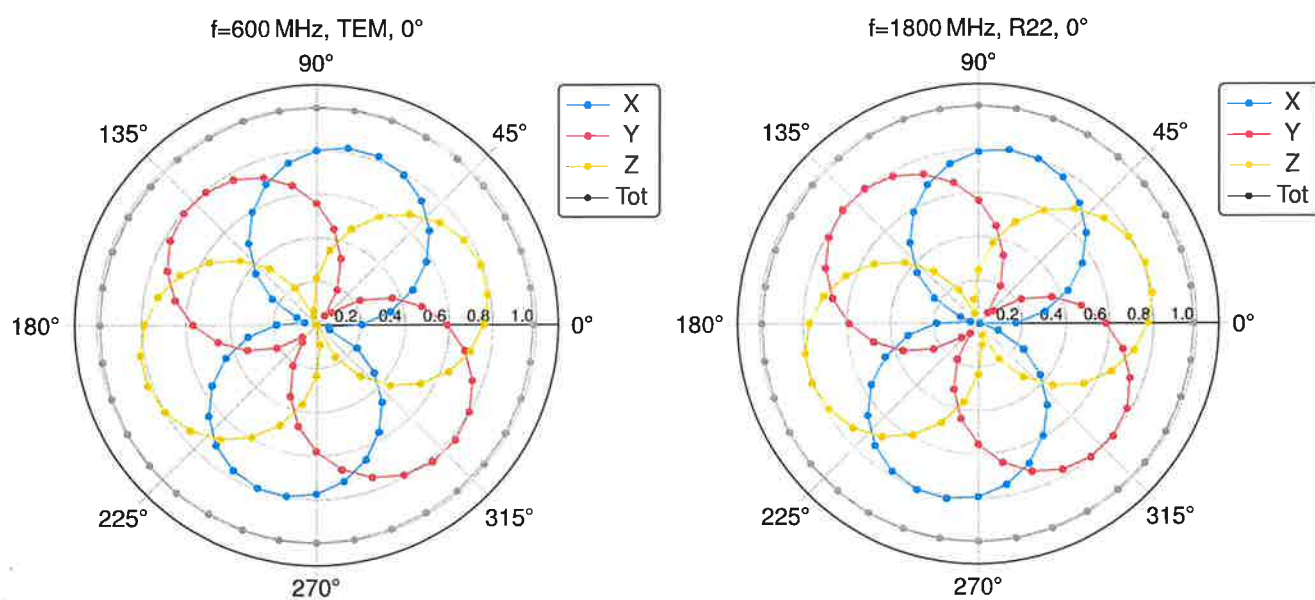
^H The stated uncertainty is the total calibration uncertainty (k = 2) of Norm-ConvF. This is equivalent to the uncertainty component with the symbol CF in Table 9 of IEC/IEEE 62209-1528:2020.

Frequency Response of E-Field

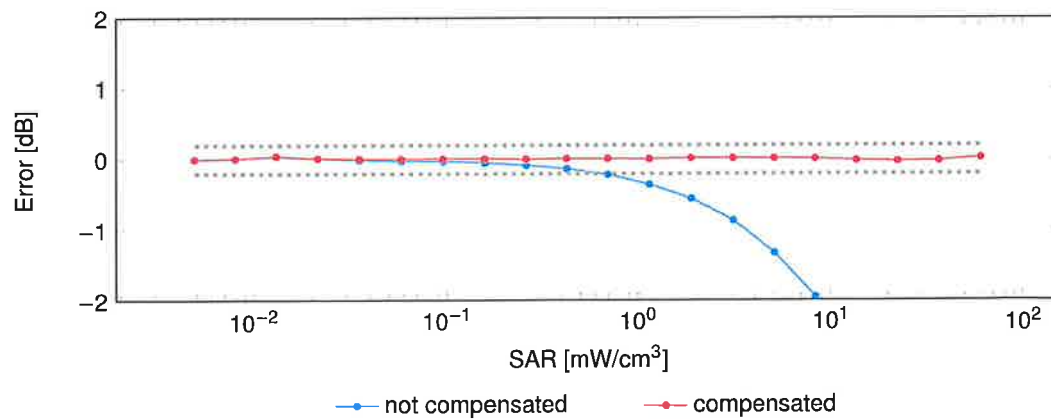
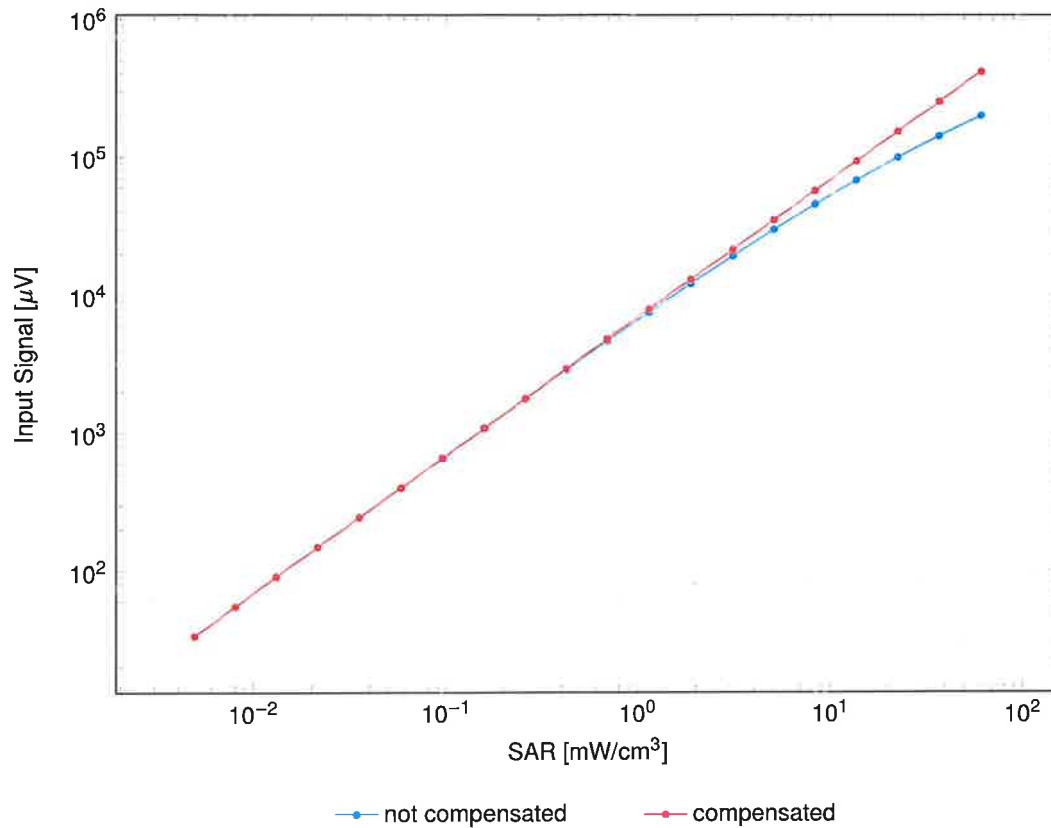
(TEM-Cell:ifi1110 EXX, Waveguide:R22)



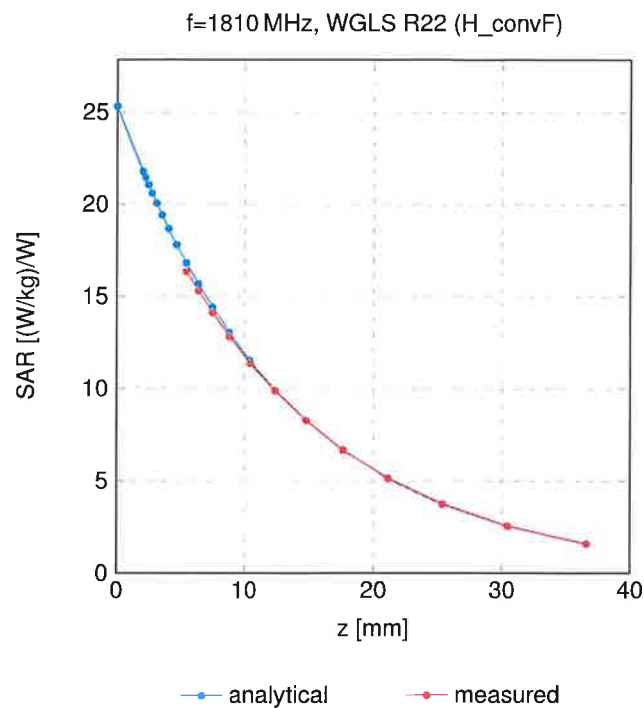
Uncertainty of Frequency Response of E-field: $\pm 6.3\%$ ($k=2$)

Receiving Pattern (ϕ), $\vartheta = 0^\circ$ 

Uncertainty of Axial Isotropy Assessment: $\pm 0.5\%$ ($k=2$)

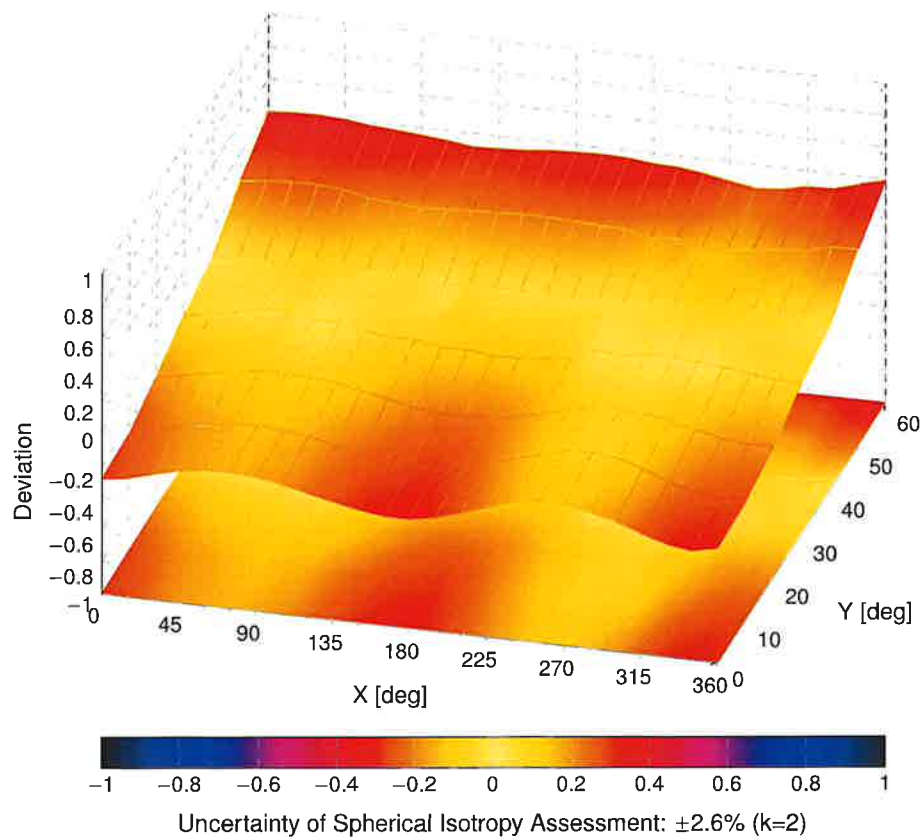
Dynamic Range $f(\text{SAR}_{\text{HSL}})$ **(TEM cell, $f_{\text{eval}} = 1900\text{MHz}$)**Uncertainty of Linearity Assessment: $\pm 0.6\%$ ($k=2$)

Conversion Factor Assessment



Deviation from Isotropy in Liquid

Error (ϕ, θ), $f = 900\text{ MHz}$



Calibration Laboratory of**Schmid & Partner
Engineering AG**

Zeughausstrasse 43, 8004 Zurich, Switzerland

**S** Schweizerischer Kalibrierdienst
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Multilateral Agreement for the recognition of calibration certificates****Accreditation No.: SCS 0108**

Client

Ultratech Labs
Oakville, Canada

Certificate No.

D2450V2-821_Mar25**CALIBRATION CERTIFICATE**

Object

D2450V2 - SN: 821

Calibration procedure(s)

QA CAL-05.v12**Calibration Procedure for SAR Validation Sources between 0.7 - 3 GHz**

Calibration date

March 31, 2025

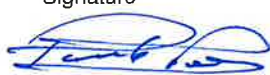
This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI).
The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate.

All calibrations have been conducted in the closed laboratory facility: environment temperature $(22 \pm 3)^{\circ}\text{C}$ and humidity $< 70\%$.

Calibration Equipment used (M&TE critical for calibration)

Primary Standards	ID	Cal Date (Certificate No.)	Scheduled Cal
Power Sensor R&S NRP-33T	SN: 100967	26-Mar-25 (No. 217-04290)	Mar-26
Power Sensor R&S NRP18A	SN: 101859	06-Feb-25 (No. 4030A315009541)	Feb-26
Spectrum Analyzer R&S FSV40	SN: 101832	29-Jan-25 (No. 4030A315009658)	Jan-26
Mismatch; Short [S4188] Attenuator [S4423]	SN: 1152	24-Mar-25 (No. 217-04293)	Mar-26
OCP DAK-12	SN: 1016	24-Sept-24 (No. OCP-DAK12-1016_Sep24)	Sep-25
OCP DAK-3.5	SN: 1249	23-Sept-24 (No. OCP-DAK3.5-1249_Sep24)	Sep-25
Reference Probe EX3DV4	SN: 7349	10-Jan-25 (No. EX3-7349_Jan25)	Jan-26
DAE4ip	SN: 1836	28-Oct-24 (No. DAE4ip-1836_Oct24)	Oct-25

Secondary Standards	ID	Check Date (in house)	Scheduled Check
ACAD Source Box	SN: 1000	28-May-24 (No. 675-ACAD_Source_Box-240528)	May-25
Signal Generator R&S SMB100A	SN: 182081	28-May-24 (No. 675-CAL16-S4588-240528)	May-25
Mismatch; SMA	SN: 1102	22-May-24 (No. 675-Mismatch_SMA-240522)	May-25

	Name	Function	Signature
Calibrated by	Paulo Pina	Laboratory Technician	
Approved by	Sven Kühn	Technical Manager	
Issued: March 31, 2025			
This calibration certificate shall not be reproduced except in full without written approval of the laboratory.			

Calibration Laboratory of

Schmid & Partner
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Zeughausstrasse 43, 8004 Zurich, Switzerland



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S Servizio svizzero di taratura
S Swiss Calibration Service

Accredited by the Swiss Accreditation Service (SAS)

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Accreditation No.: SCS 0108

Glossary

TSL tissue simulating liquid
ConvF sensitivity in TSL / NORM x,y,z
N/A not applicable or not measured

Calibration is Performed According to the Following Standards

- IEC/IEEE 62209-1528, "Measurement Procedure For The Assessment Of Specific Absorption Rate Of Human Exposure To Radio Frequency Fields From Hand-Held And Body-Worn Wireless Communication Devices - Part 1528: Human Models, Instrumentation And Procedures (Frequency Range of 4 MHz to 10 GHz)", October 2020.
- KDB 865664, "SAR Measurement Requirements for 100 MHz to 6 GHz"

Additional Documentation

- DASY System Handbook

Methods Applied and Interpretation of Parameters

- *Measurement Conditions*: Further details are available from the Validation Report at the end of the certificate. All figures stated in the certificate are valid at the frequency indicated.
- *Antenna Parameters with TSL*: The dipole is mounted with the spacer to position its feed point exactly below the center marking of the flat phantom section, with the arms oriented parallel to the body axis.
- *Feed Point Impedance and Return Loss*: These parameters are measured with the dipole positioned under the liquid filled phantom. The impedance stated is transformed from the measurement at the SMA connector to the feed point. The Return Loss ensures low reflected power. No uncertainty required.
- *Electrical Delay*: One-way delay between the SMA connector and the antenna feed point. No uncertainty required.
- *SAR measured*: SAR measured at the stated antenna input power.
- *SAR normalized*: SAR as measured, normalized to an input power of 1 W at the antenna connector.
- *SAR for nominal TSL parameters*: The measured TSL parameters are used to calculate the nominal SAR result.

The reported uncertainty of measurement is stated as the standard uncertainty of measurement multiplied by the coverage factor $k=2$, which for a normal distribution corresponds to a coverage probability of approximately 95%.

Measurement Conditions

DASY system configuration, as far as not given on page 1.

DASY Version	DASY8 Module SAR	16.4.0
Extrapolation	Advanced Extrapolation	
Phantom	Modular Flat Phantom	
Distance Dipole Center - TSL	10 mm	with spacer
Zoom Scan Resolution	dx, dy = 5mm, dz = 1.5mm	Graded Ratio = 1.5 mm (Z direction)
Frequency	2450MHz $\pm$ 1MHz	

HSL parameters at 2450 MHz

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal HSL parameters	22.0 °C	39.2	1.80 mho/m
Measured HSL parameters	(22.0 $\pm$ 0.2)°C	38.0 $\pm$ 6%	1.85 mho/m $\pm$ 6%
HSL temperature change during test	< 0.5 °C		

SAR result with HSL at 2450 MHz

SAR averaged over 1 cm³ (1 g) of HSL	Condition	
SAR for nominal HSL parameters	24 dBm input power	13.3 W/kg
SAR for nominal HSL parameters	normalized to 1W	52.9 W/kg $\pm$ 17.0% (k = 2)

SAR averaged over 10 cm³ (10 g) of HSL	Condition	
SAR for nominal HSL parameters	24 dBm input power	6.26 W/kg
SAR for nominal HSL parameters	normalized to 1W	24.9 W/kg $\pm$ 16.5% (k = 2)

MSL parameters at 2450 MHz

The following parameters and calculations were applied.

	Temperature	Permittivity	Conductivity
Nominal MSL parameters	22.0 °C	52.7	1.95 mho/m
Measured MSL parameters	(22.0 ±0.2)°C	52.1 ±6%	2.04 mho/m ±6%
MSL temperature change during test	< 0.5 °C		

SAR result with MSL at 2450 MHz

SAR averaged over 1 cm ³ (1 g) of MSL	Condition	
SAR for nominal MSL parameters	24 dBm input power	12.7 W/kg
SAR for nominal MSL parameters	normalized to 1W	50.6 W/kg ±17.0% (k = 2)

SAR averaged over 10 cm ³ (10 g) of MSL	Condition	
SAR for nominal MSL parameters	24 dBm input power	6.03 W/kg
SAR for nominal MSL parameters	normalized to 1W	24.0 W/kg ±16.5% (k = 2)

Appendix (Additional assessments outside the scope of SCS 0108)**Antenna Parameters with HSL at 2450 MHz**

Impedance	54.7 Ω + 4.3 j Ω
Return Loss	-24.3 dB

Antenna Parameters with MSL at 2450 MHz

Impedance	50.0 Ω + 5.0 j Ω
Return Loss	-26.1 dB

General Antenna Parameters and Design

Electrical Delay (one direction)	1.159 ns
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After long term use with 100W radiated power, only a slight warming of the dipole near the feedpoint can be measured. The dipole is made of standard semirigid coaxial cable. The center conductor of the feeding line is directly connected to the second arm of the dipole. The antenna is therefore short-circuited for DC-signals. On some of the dipoles, small end caps are added to the dipole arms in order to improve matching when loaded according to the position as explained in the "Measurement Conditions" paragraph. The SAR data are not affected by this change. The overall dipole length is still according to the Standard. No excessive force must be applied to the dipole arms, because they might bend or the soldered connections near the feedpoint may be damaged.

Additional EUT Data

Manufactured by	SPEAG
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System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]
D2450V2 - SN821	2450	HSL	24

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat	10	CW, 0--		2450, 0	7.06	1.85	38.0

Hardware Setup

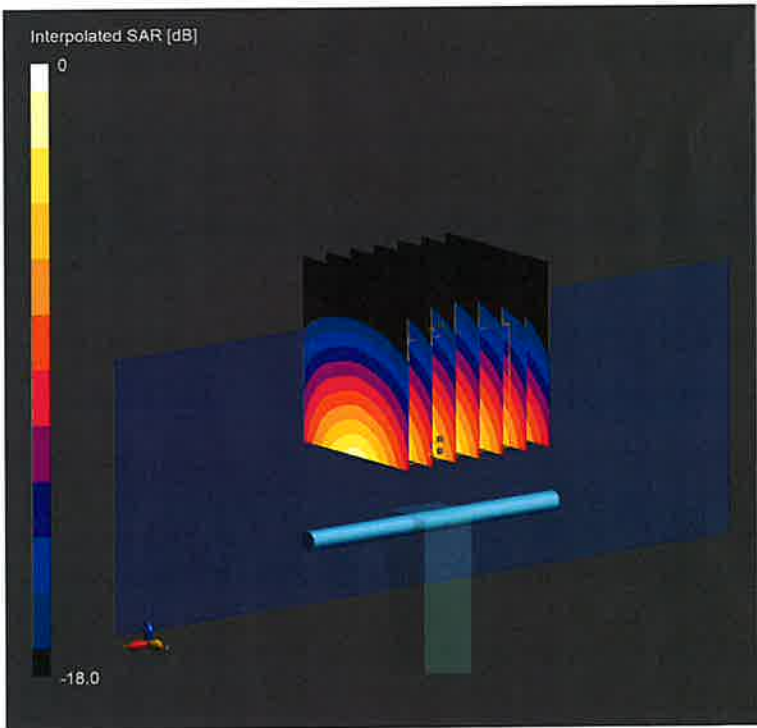
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
MFP V8.0 Center	HSL, 2025-03-28	EX3DV4 - SN7349, 2025-01-10	DAE4ip Sn1836, 2024-10-28

Scans Setup

	Zoom Scan
Grid Extents [mm]	30 x 30 x 30
Grid Steps [mm]	5.0 x 5.0 x 1.5
Sensor Surface [mm]	1.4
Graded Grid	Yes
Grading Ratio	1.5
MAIA	N/A
Surface Detection	VMS + 6p
Scan Method	Measured

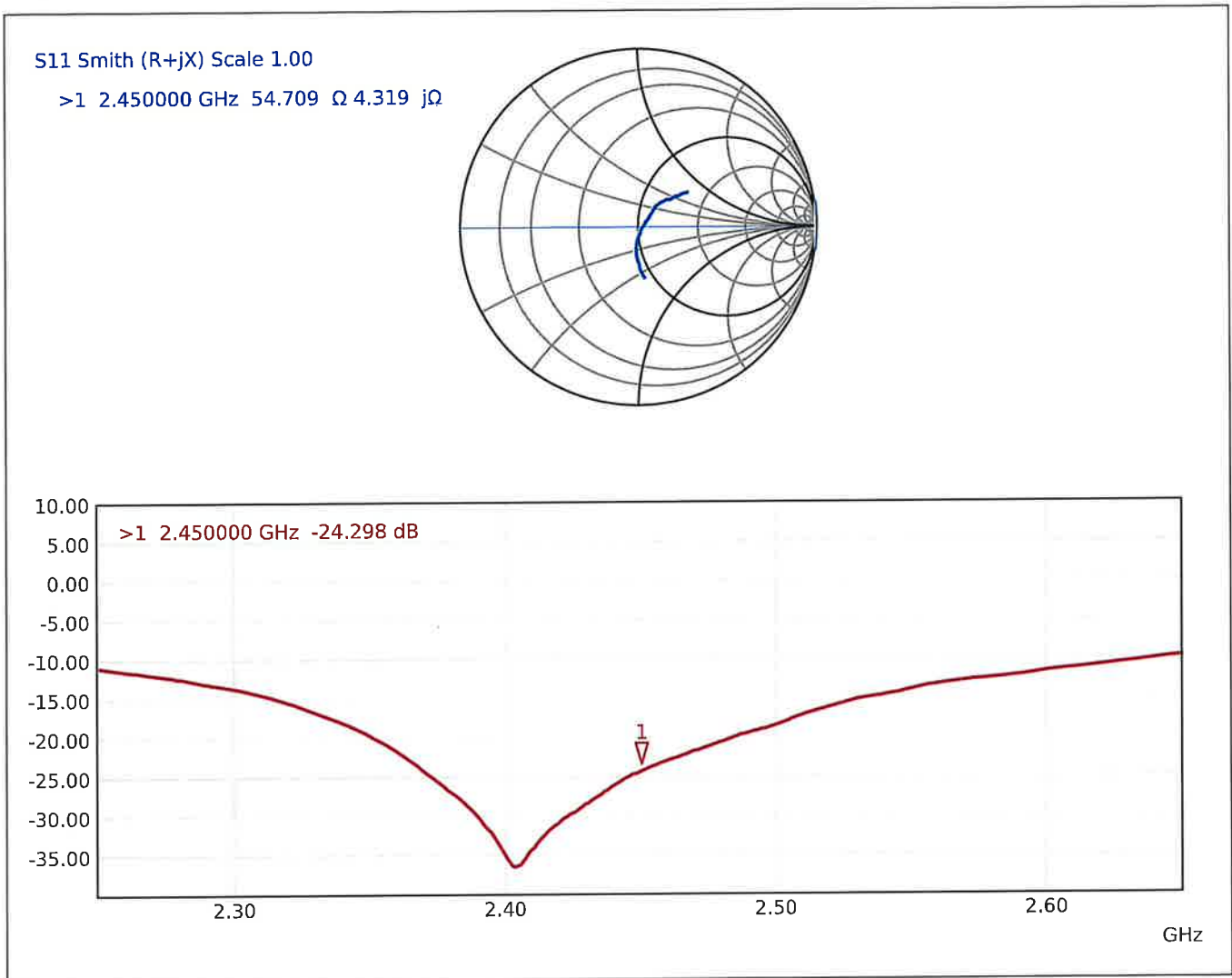
Measurement Results

	Zoom Scan
Date	2025-03-28
psSAR1g [W/Kg]	13.3
psSAR10g [W/Kg]	6.26
Power Drift [dB]	0.00
Power Scaling	Disabled
Scaling Factor [dB]	
TSL Correction	Positive / Negative



0 dB = 27.3 W/Kg

Impedance Measurement Plot for HSL



System Performance Check Report

Summary

Dipole	Frequency [MHz]	TSL	Power [dBm]
D2450V2 - SN821	2450	MSL	24

Exposure Conditions

Phantom Section, TSL	Test Distance [mm]	Band	Group, UID	Frequency [MHz], Channel Number	Conversion Factor	TSL Conductivity [S/m]	TSL Permittivity
Flat	10	CW, 0--		2450, 0	7.06	2.04	52.1

Hardware Setup

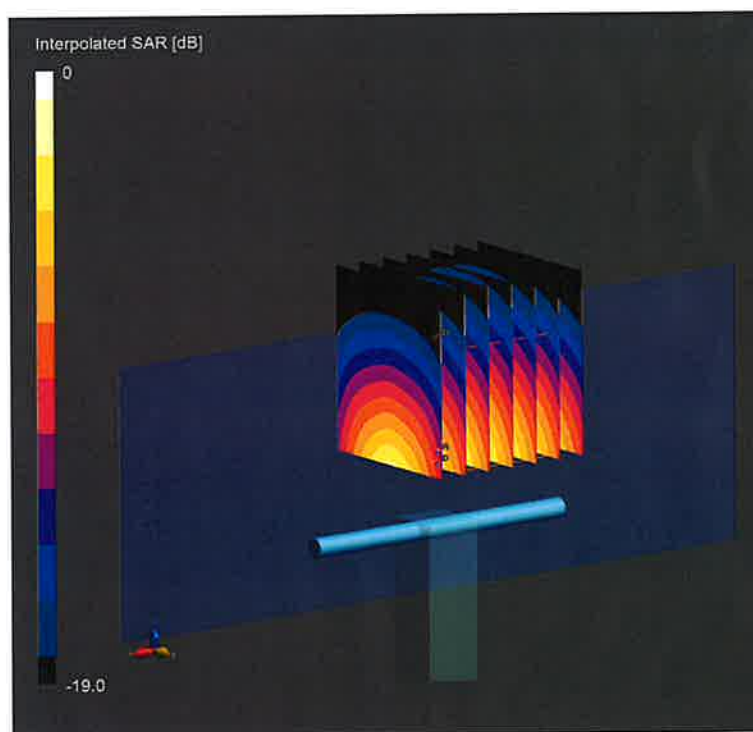
Phantom	TSL, Measured Date	Probe, Calibration Date	DAE, Calibration Date
MFP V8.0 Right	MSL, 2025-03-31	EX3DV4 - SN7349, 2025-01-10	DAE4ip Sn1836, 2024-10-28

Scans Setup

	Zoom Scan
Grid Extents [mm]	30 x 30 x 30
Grid Steps [mm]	5.0 x 5.0 x 1.5
Sensor Surface [mm]	1.4
Graded Grid	Yes
Grading Ratio	1.5
MAIA	N/A
Surface Detection	VMS + 6p
Scan Method	Measured

Measurement Results

	Zoom Scan
Date	2025-03-31
psSAR1g [W/Kg]	12.7
psSAR10g [W/Kg]	6.03
Power Drift [dB]	0.01
Power Scaling	Disabled
Scaling Factor [dB]	
TSL Correction	Positive / Negative



0 dB = 25.4 W/Kg

Impedance Measurement Plot for MSL

